Search Notes	i

Application/Control No.	Applicant(s)/Patent under Reexamination
10/511,539	NAKANISHI, MASAHIRO
Examiner	Art Unit
Almis R. Jankus	2628

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES:: (INCLUDING SEARCH STRATEGY)			
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USPAY FILE ACM IEEE FRAME RATE		3/2/07	2
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